Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/751,520	FURUKAWA ET AL.	FURUKAWA ET AL.	
Examiner	Art Unit		
Laura E. Martin	2853		

SEARCHED					
Class	Subclass	Date	Examiner		
347	15	3/15/2006	LEM		
358	1.9	3/15/2006	LEM		
358	2.1	3/15/2006	LEM		
358	1.2	3/15/2006	LEM		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
347	15, 19	3/15/2006	LEM	
358	1.9	3/15/2006	LEM	
358	2.1, 1.2	3/15/2006	LEM	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see attached search notes; talked to Lamson Nguyen and Scott Rodgers about search and novelty	3/15/2006	LEM	